Electronic Supplementary Information

Highly Inter-connected Nanorods and Nanosheets Based on Hierarchically
Layered MOF for Flexible, High-Performance Energy Storage Device

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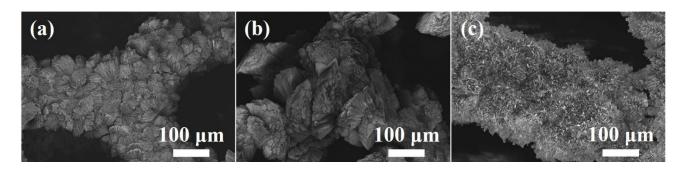


Figure S1. Demagnified SEM images of (a) hl-MOF, (b) u-hl-MOF and (c) u-hl-MOF/NRSs on Ni foam.

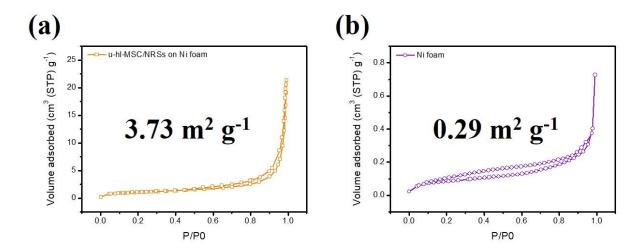


Figure S2. N₂ sorption isotherm of (a) u-hl-MSC/NRSs on Ni foam and (b) bare Ni foam.

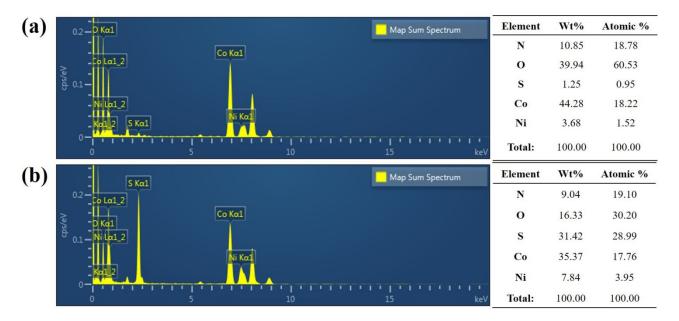


Figure S3. EDS spectrum and calculated element ratio table of (a) u-hl-MSC section and (b) NRs section.

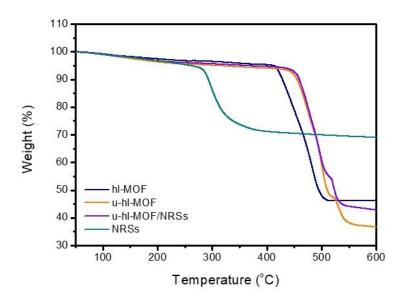


Figure S4. TGA curves of hl-MOF, u-hl-MOF, u-hl-MOF/NRSs and NRSs (collected from the residue powder in autoclave container) under N_2 atmosphere.

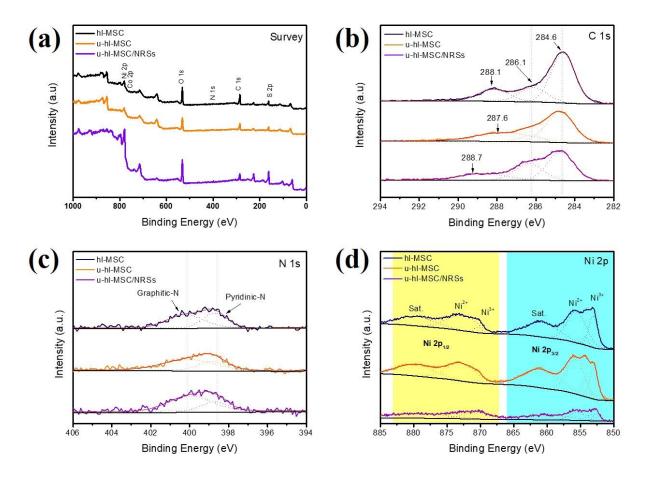


Figure S5. XPS spectra of (a) survey scan and the deconvoluted spectra for specific elements of (b) C 1s, (c) N 1s and (d) Ni 2p for hl-MSC, u-hl-MSC, and u-hl-MSC/NRSs on Ni foam.

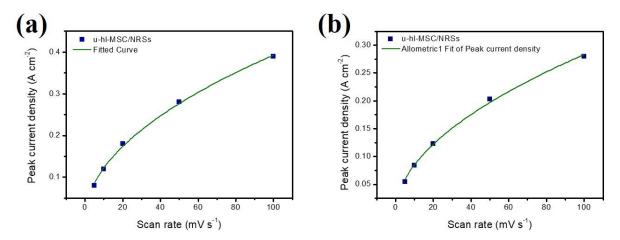


Figure S6. Peak current density curve according to scan rate from (a) cathodic reaction and (b) anodic reaction to calculate the *b* value from equation.

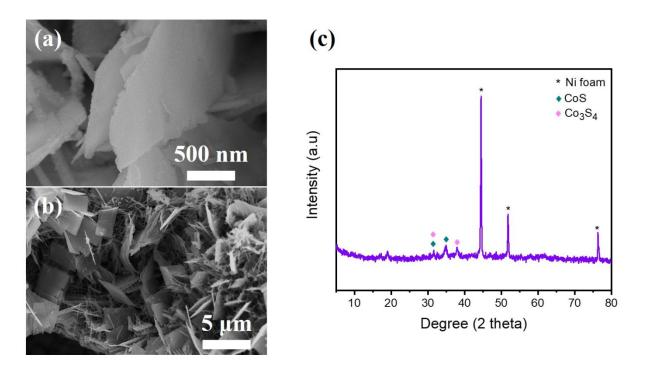


Figure S7. (a,b) SEM image and (c) XRD spectrum of u-hl-MSCs electrode after 10000 cycles.

 Table S1. Surface atomic percent (%) component determined from X-ray photoelectron spectroscopy.

Sample _	Concentration [atomic %]						
	С	Co	N	Ni	О	S	
hl-MSC	44.29	4.15	2.21	10.62	27.89	10.84	
u-hl-MSC	39.47	3.49	2.63	14.85	28.63	10.93	
u-hl-MSC/NRSs	23.75	17.91	1.85	3.31	29.47	23.7	